

1. ZnSe substrate

Refractive index – Sellmeier model

$$n^2(\lambda) = A_0 + \frac{A_1\lambda^2}{\lambda^2 - A_2} + \frac{A_3\lambda^2}{\lambda^2 - A_4} + \frac{A_5\lambda^2}{\lambda^2 - A_6} \quad \text{Eq. 1}$$

with $A_0 = 0.310182$, $A_1 = 4.855169$, $A_2 = 0.056359$, $A_3 = 0.673922$, $A_4 = 0.056336$, $A_5 = 2.481890$,

$A_6 = 2222.114$ numerical values are in ZnSe_nk.xlsx file.

Extinction coefficient – table values (see ZnSe_nk.xlsx file), non-parametric approach was used

2. Ge substrate

Refractive index, extinction coefficient – table data (Ge substrate_nk.xlsx), non-parametric approach

3. ZnS

Refractive index – Sellmeier model (Eq. 1) with $A_0 = 1.010356$, $A_1 = 3.619092$, $A_2 = 0.02345364$, $A_3 = 0.508130$, $A_4 = 0.099946$, $A_5 = 2.219955$, $A_6 = 1148.729$

Extinction coefficient – exponential model

$$k(\lambda) = B_0 \cdot \exp\{B_1\lambda^{-1} + B_2\lambda\} \quad \text{Eq. 2}$$

With $B_0 = 0.03970$, $B_1 = -0.080715$, $B_2 = -7.074209$.

Numerical values are in ZnS_nk.xlsx

4. YbF3

Refractive index – Cauchy model $n(\lambda) = A_0 + \frac{A_1}{\lambda^2} + \frac{A_2}{\lambda^4}$, with $A_0 = 1.484489$, $5.4996 \cdot 10^{-5}$,

$2.6266 \cdot 10^{-3}$.

Extinction coefficient – table data, non-parametric approach.

Numerical values are in YbF3_nk.xlsx

5. LaF3

Refractive index – Sellmeier model Eq. 1 with

$A_0 = 0.187042$, $A_1 = 2.030974$, $A_2 = 0.01057737$, $A_3 = 0.024492$, $A_4 = -0.851254$, $A_5 = 4.544580$,

$A_6 = 1149.999773$

Extinction coefficient – table data, non-parametric approach

Numerical values are in LaF3_nk.xlsx

6. Ge film

Refractive index and extinction coefficient – table data, non-parametric approach

Numerical values are in Ge film_nk.xlsx

All four films were produced using e-beam evaporation, substrate temperature was 120 degrees.